


<b>Search Notes</b> 	<b>Application/Control No.</b> 10629033	<b>Applicant(s)/Patent Under Reexamination</b> MAYO ET AL.
	<b>Examiner</b> Wai, Eric C	<b>Art Unit</b> 2195

SEARCHED			
Class	Subclass	Date	Examiner
709	229, 219	03/07/07	ECW
713	324	03/07/07	ECW
600	407	03/07/07	ECW
718	102-105	4/17/2008	ECW

SEARCH NOTES		
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Inventor's Name Search	03/07/07	ECW
East Search	03/07/07	ECW
Updated Search	10/10/2007	ECW
Google Scholar Search	10/10/2007	ECW
Updated East Search	4/17/2008	ECW
Updated East Search	10/24/2008	ECW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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